

FIG. 1

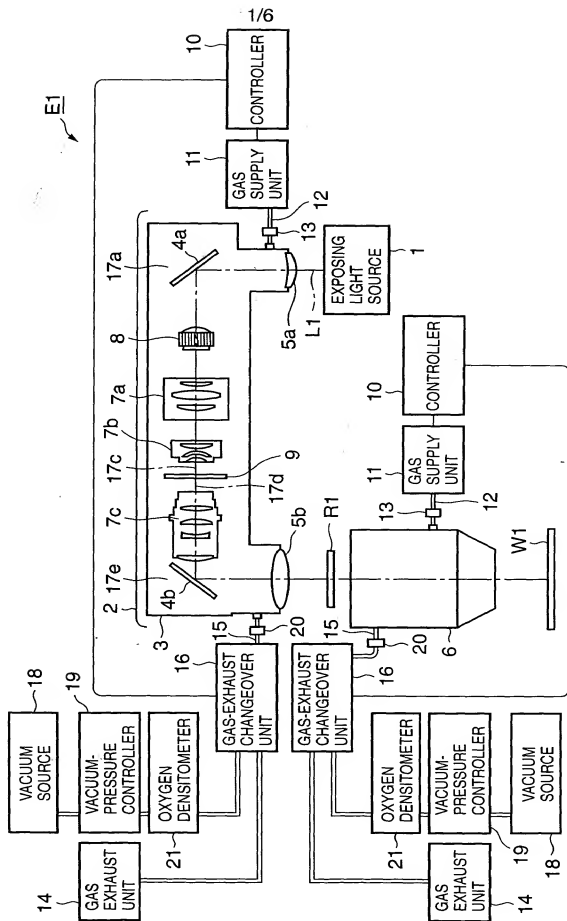


FIG. 2

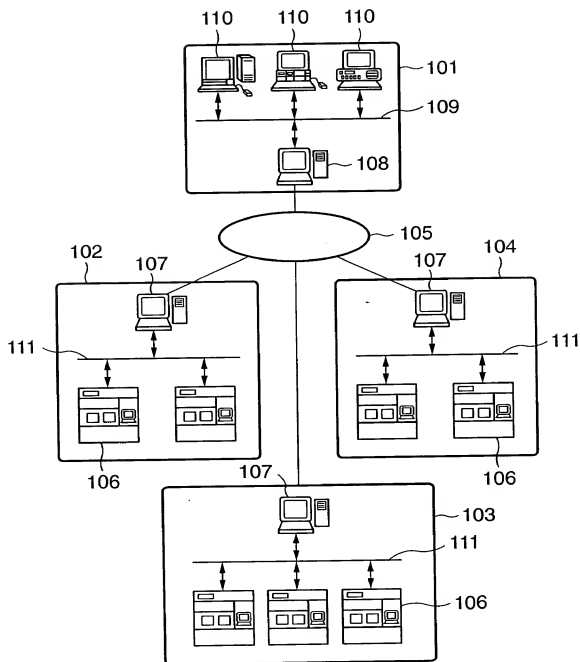


FIG. 3

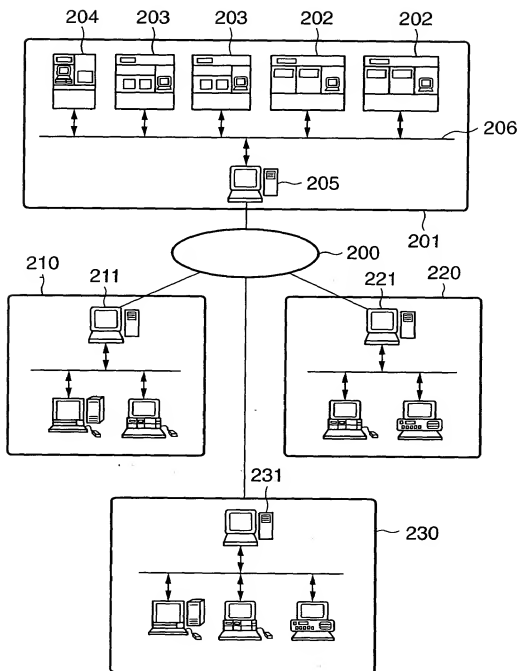


FIG. 4

URL

MALFUNCTION DATABASE INPUT SCREEN

DATE OF OCCURRENCE  404

MODEL  401

SUBJECT MATTER  403

EQUIPMENT SERIAL NO.  402

DEGREE OF URGENCY  405

CONDITION  406

COUNTERMEASURE METHOD  407

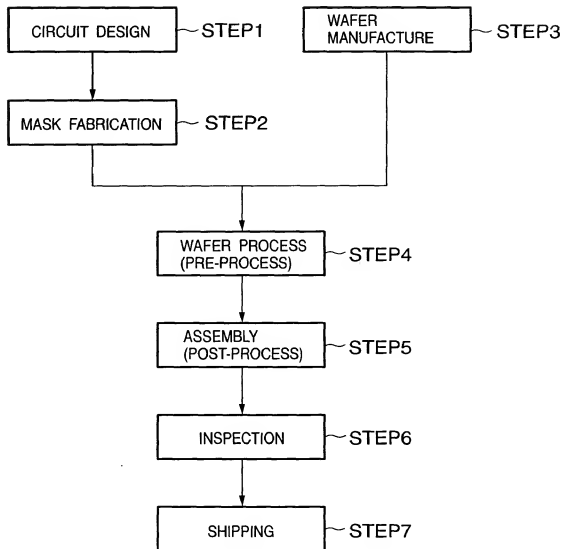
PROGRESS REPORT  408

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[LINK TO DATABASE OF RESULTS](#) [SOFTWARE LIBRARY](#) [OPERATING GUIDE](#)

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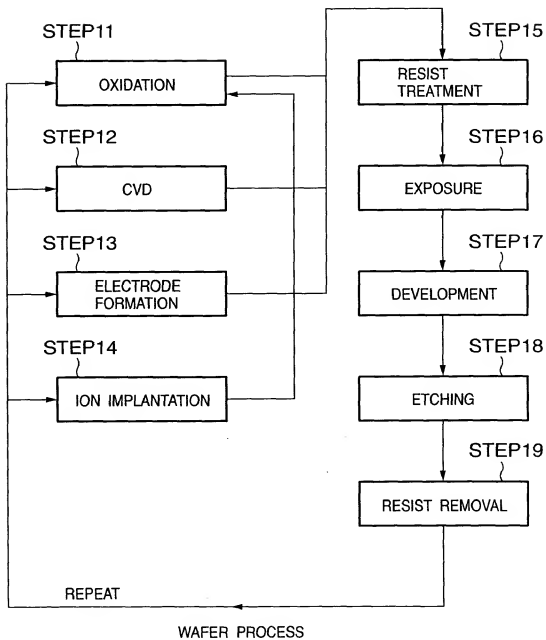
FIG. 5



FLOW OF SEMICONDUCTOR DEVICE MANUFACTURE

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FIG. 6



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